

SPN4506S8RGB-VB Datasheet

N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
40	0.0038 at V _{GS} = 10 V	18	8 nC			
	0.0057 at V _{GS} = 4.5 V	14.5	0110			

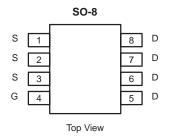
FEATURES

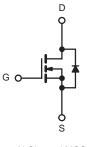
- Halogen-free According to IEC 61249-2-21
- Trench Power MOSFET ٠
- 100 % R_g and UIS Tested ٠

APPLICATIONS

- Notebook CPU Core
 - High-Side Switch







N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		18		
Continuous Drain Current (T ₁ = 150 °C)	T _C = 70 °C		13.5		
Continuous Drain Current $(T_j = 150^{\circ} C)$	T _A = 25 °C	^I D	12 ^{b, c}		
	T _A = 70 °C		9.6 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	50	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	1.	4.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is Is	2.2 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	20		
Avalanche Energy		E _{AS}	20	mJ	
	T _C = 25 °C		5		
Maximum Bower Discipation	T _C = 70 °C	P _D	3.2	w	
Maximum Power Dissipation	T _A = 25 °C	'D	2.5 ^{b, c}	vv	
	T _A = 70 °C	1	1.6 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	38	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	20	25	0/10		

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface Mounted on 1" x 1" FR4 board. c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static		·				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$	40			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{\perp}$			34		m)//00
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- Ι _D = 250 μΑ		- 4.7		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.0		3.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zana Cata Maltana Drain Correct	I _{DSS}	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA
Zero Gate Voltage Drain Current		$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	30			А
	6	V _{GS} = 10 V, I _D = 10 A		0.0038		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 7 A		0.0057		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		30		S
Dynamic ^b			1			<u>I</u>
Input Capacitance	C _{iss}			985		pF
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		205		
Reverse Transfer Capacitance	C _{rss}	1		76		
Total Gate Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	18	27	1	
				8	12	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.4		
Gate-Drain Charge	Q _{gd}	1		2.3		
Gate Resistance	R _g	f = 1 MHz	0.3	1.3	2.6	Ω
Turn-On Delay Time	t _{d(on)}			14	25	ns
Rise Time	t _r	V _{DD} = 15 V, R _L = 1.5 Ω		12	24	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		19	35	
Fall Time	t _f	1		9	18	
Turn-On Delay Time	t _{d(on)}			8	16	
Rise Time	t _r	V _{DD} = 15 V, R _L = 1.5 Ω		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		16	30	
Fall Time	t _f	1		9	18	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			4.5	
Pulse Diode Forward Current ^a	I _{SM}				50	A
Body Diode Voltage	V _{SD}	I _S = 3 A		0.76	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			14	28	ns
Body Diode Reverse Recovery Charge	Q _{rr}			5	10	nC
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		8		
Reverse Recovery Rise Time	t _b			6	L	ns

Notes:

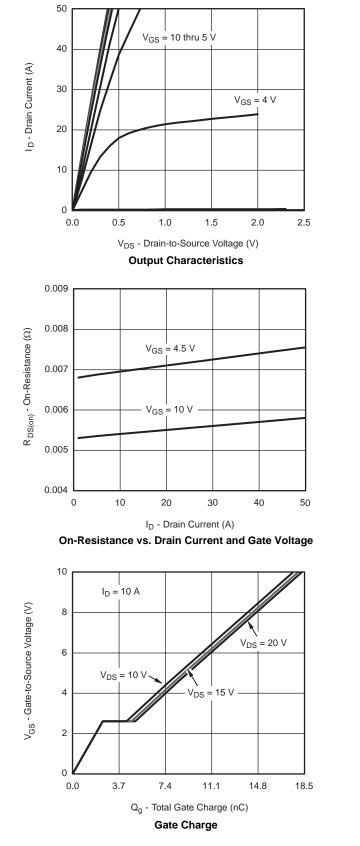
a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %

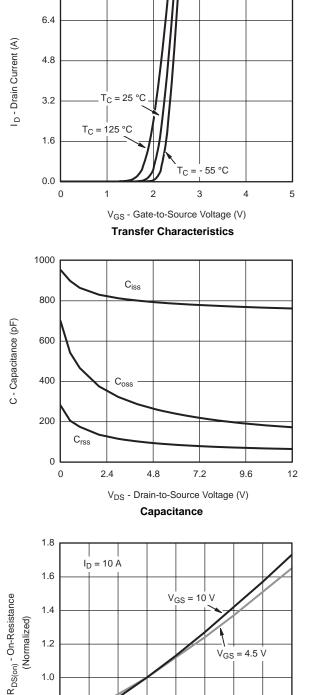
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





8.0

1.2

1.0

0.8

0.6

- 50

- 25

0

25

50

T_J - Junction Temperature (°C) **On-Resistance vs. Junction Temperature**

75



 $V_{GS} = 4.5 V$

100

125

150

100



10

10

0.010 10 T_{.1} = 150 °C $R_{DS(on)}$ - On-Resistance ($\Omega)$ Is - Source Current (A) T_J = 25 °C 0.008 1 0.006 0.1 T_J = 125 °C 0.004 0.01 T_J = 25 °C 0.001 0.002 0.0 0.2 0.4 0.6 0.8 1.0 1.2 0 1 2 3 4 5 6 7 8 9 V_{SD} - Source-to-Drain Voltage (V) V_{GS} - Gate-to-Source Voltage (V) Source-Drain Diode Forward Voltage On-Resistance vs. Gate-to-Source Voltage 0.4 80 0.2 64 V_{GS(th)} Variance (V) 0 Power (W) 48 - 0.2 $I_D = 5 \text{ mA}$ 32 - 0.4 $I_D = 250 \ \mu A$ 16 - 0.6 - 0.8 0 - 25 - 50 0 25 50 75 100 125 150 0.001 0.01 0.1 1 T_J - Temperature (°C) Time (s) **Threshold Voltage** Single Pulse Power, Junction-to-Ambient 100 Limited by RDS(on 10 I_D - Drain Current (A) ms 10 ms 100 ms 1 s 0.1 10 s $T_A = 25 \ ^{\circ}C$ Single Pulse DC **BVDSS** Limited

1

 $\label{eq:VDS} V_{DS} \mbox{-} Drain-to-Source \mbox{Voltage (V)} $$ V_{GS} \mbox{-} minimum \mbox{V}_{GS} \mbox{at which } R_{DS(on)} \mbox{ is specified} $$$ Safe Operating Area, Junction-to-Ambient

10

100

0.01 L

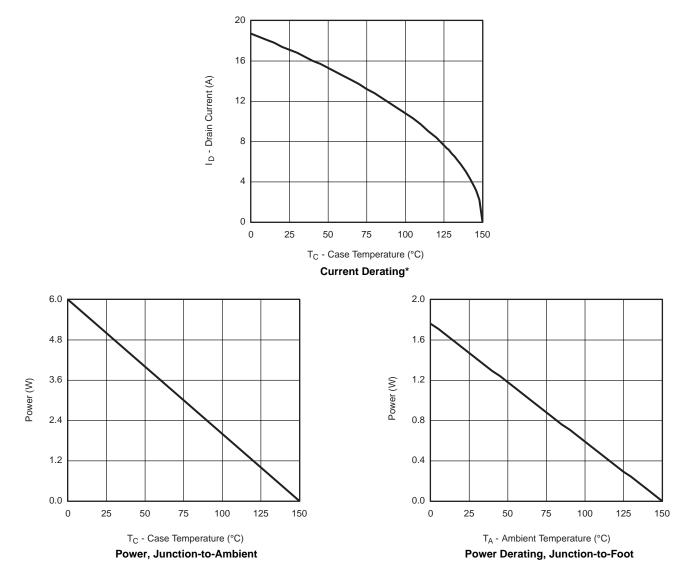
0.012

 $I_{D} = 10 \text{ Å}$

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



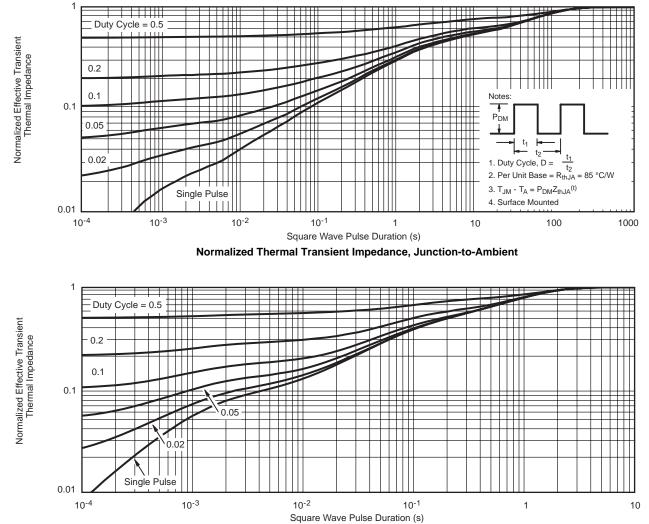
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 C, unless otherwise noted

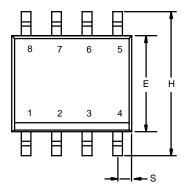


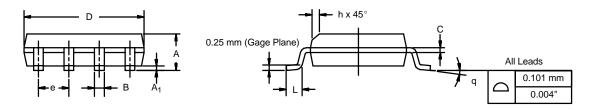
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

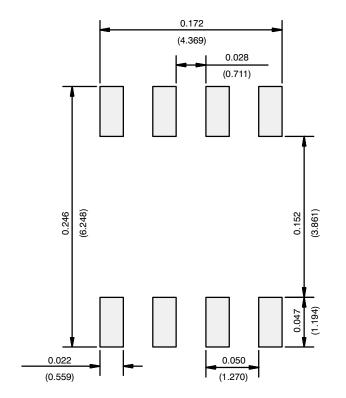




	MILLIM	IETERS	INCHES		
DIM	Min	Max	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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